PCTEST

PCTEST ENGINEERING LABORATORY, INC.

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HEARING AID COMPATIBILITY CERTIFICATE

Applicant Name:

Nokia Inc. 12278 Scripps Summit Drive San Diego, CA 92131-3697 United States Date of Testing:

4/6/2009

Test Site/Location:

PCTEST Lab, Columbia, MD, USA

Test Report Serial No.:

0903180521.QMN

FCC ID: QMNRM-526

APPLICANT: NOKIA INC.

Application Type: Certification

FCC Rule Part(s): § 20.19(b), §6.3(v), §7.3(v) **HAC Standard:** ANSI C63.19-2007;

FCC Classification: Licensed Transmitter Held to Ear (PCE)

EUT Type: Dual-Band CDMA/EVDO Phone with+BT2.1+EDR

Model(s): RM-526

Tx Frequency: 824.70 - 848.31 MHz (Cellular CDMA) 1851.25 - 1908.75 MHz (PCS CDMA)

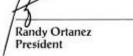
Test Device Serial No.: Pre-Production Sample [S/N: A00000016703A2]

C63.19-2007 HAC Category: M4 (RF EMISSIONS CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2007 and had been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

PCTEST certifies that no party to this application has been denied the FCC benefits pursuant to Section 5301 of the Anti-Drug Abuse Act of 1988, 21 U.S.C. 862.





FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 1 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Page 1 0175

TABLE OF CONTENTS

1.	INTRODUCTION	3
2.	TEST SITE LOCATION	4
3.	EUT DESCRIPTION	5
4.	ANSI/IEEE C63.19 PERFORMANCE CATEGORIES	6
5.	SYSTEM SPECIFICATIONS	7
6.	TEST PROCEDURE	13
7.	SYSTEM CHECK	15
8.	MODULATION FACTOR	18
9.	FCC 3G MEASUREMENTS	20
10.	OVERALL MEASUREMENT SUMMARY	22
11.	EQUIPMENT LIST	25
12.	MEASUREMENT UNCERTAINTY	26
13.	TEST DATA	27
14.	CALIBRATION CERTIFICATES	36
15.	CONCLUSION	70
16.	REFERENCES	71
17.	TEST PHOTOGRAPHS	73

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 2 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 2 UI / 3

1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- RF Magnetic-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid in-vitu

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 3 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+E	BT2.1+EDR	rage 3 01 75

2. TEST SITE LOCATION

2.1 INTRODUCTION

The map at the right shows the location of the PCTEST LABORATORY in Columbia, Maryland. It is in proximity to the FCC Laboratory, the Baltimore-Washington International (BWI) airport, the city of Baltimore and Washington, DC (See Figure 2).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49' 38" W longitude. The facility is 1.5 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to



Figure 2-1
Map of the Greater Baltimore and Metropolitan
Washington D.C. area

those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4 on January 27, 2006 and Industry Canada.

2.2 Test Facility / Accreditations:

Measurements were performed at an independent accredited PCTEST Engineering Lab located in Columbia, MD 21045, U.S.A.



- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing-Aid Compatibility (HAC), CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC-2451).
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).



- PCTEST facility is an IC registered (IC-2451) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS and CDMA, and EvDO mobile phones.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for Over-the-Air (OTA)
 Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS
 (W-CDMA), CDMA 1xEVDO Data, CDMA 1xRTT Data.



FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 4 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	+BT2.1+EDR	Fage 4 of 75

3. EUT DESCRIPTION

NOKIA

FCC ID: QMNRM-526 Manufacturer: Nokia Inc.

12278 Scripps Summit Drive San Diego, CA 92131-3697

United States

Trade Name: Nokia Model(s): RM-526

Serial Number: A000000016703A2

Tx Frequencies: 824.70 - 848.31 MHz (Cellular CDMA)

1851.25 - 1908.75 MHz (PCS CDMA)

Antenna Configurations: Internal Antenna

1S98D(CDMA2000) Unit : dBm Cell PCS Config 777 25 600 1175 1013 384 RC1 SO2 24.41 24.32 24.50 24.31 24.10 24.33 RC1 8055 24.50 24.22 24.33 24.03 24.42 RC2 SO9 24.42 24.31 24.32 24.20 24.04 24.41 24.52 24.40 24.40 24.32 24.02 502 24.32 24.51 24.32 24.33 24.22 23.81 RC3 8032 24.42 24.43 24.20 24.22 24.13 24.13 RC3 8055 24.32 24.41 24.31 24.32 24.13 23.81 RC4 SO2 24.50 24.03 RC4 S032 24.41 24.22 24.32 24.42 24.13 24.10 RC4 S055 24.50 24.50 24.32 24.33 24.11 24.03 RC5 SO9 24.42 24.51 24.42 24.32 24.13 23.94 24.42 24.12 RC5 S055 24.42 24.51 24.31 23.92

Conducted Power (HAC):

HAC Test Configurations: CDMA, 1013, 384, 777, BT Off

PCS, 25, 600, 1175, BT Off

FCC Classification: Licensed Transmitter Held to Ear (PCE)

EUT Type: Dual-Band CDMA/EVDO Phone with+BT2.1+EDR

See Key Features list for more detailed information.

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:			Page 5 of 75
0903180521.QMN	4/6/2009	Dual-Band CDI	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		

4. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters						
Near field Category	E-field emissions CW dB(V/m)	H-field emissions CW dB(A/m)					
	f < 960 MHz						
M1	56 to 61 + 0.5 x AWF	5.6 to 10.6 +0.5 x AWF					
M2	51 to 56 + 0.5 x AWF	0.6 to 5.6 +0.5 x AWF					
M3	46 to 51 + 0.5 x AWF	-4.4 to 0.6 +0.5 x AWF					
M4	< 46 + 0.5 x AWF	< -4.4 + 0.5 x AWF					
	f > 960 MHz						
M1	46 to 51 + 0.5 x AWF	-4.4 to 0.6 +0.5 x AWF					
M2	41 to 46 + 0.5 x AWF	−9.4 to −4.4 +0.5 x AWF					
M3	36 to 41 + 0.5 x AWF	-14.4 to -9.4 +0.5 x AWF					
M4	< 36 + 0.5 x AWF	< -14.4 + 0.5 x AWF					
Table 4-1 Hearing aid and WD near-field categories as defined in ANSI C63.19-2007							

II. ARTICULATION WEIGHTING FACTOR (AWF)

Standard	Technology	Articulation Weighing Factor (AWF)				
T1/T1P1/3GPP	UMTS (WCDMA)	0				
TIA/EIA/IS-2000	CDMA	0				
iDEN ^T	TDMA (22 and 11 Hz)	0				
J-STD-007	-5					
Table 4-2 Articulation Weighting Factors						

FCC ID: QMNRM-526	PCTEST	НАС	C (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 6 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with	+BT2.1+EDR	Fage 6 01 75

5. SYSTEM SPECIFICATIONS

ER3DV6 E-Field Probe Description

Construction: One dipole parallel, two dipoles normal to probe axis

Built-in shielding against static charges

Calibration: In air from 100 MHz to 3.0 GHz

(absolute accuracy ±6.0%, k=2)

Frequency: 100 MHz to > 6 GHz;

Linearity: ± 0.2 dB (100 MHz to 3 GHz)

Directivity ± 0.2 dB in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

Dynamic Range 2 V/m to > 1000 V/m

(M3 or better device readings fall well below diode

compression point)

Linearity: $\pm 0.2 \text{ dB}$

Dimensions Overall length: 330 mm (Tip: 16 mm)

Tip diameter: 8 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 2.5 mm



Figure 5-1 E-field Free-space Probe

H3DV6 H-Field Probe Description

Construction: Three concentric loop sensors with 3.8 mm loop diameters

Resistively loaded detector diodes for linear response

Built-in shielding against static charges

Frequency: 200 MHz to 3 GHz (absolute accuracy \pm 6.0%, k=2);

Output linearized

Directivity: ± 0.25 dB (spherical isotropy error)

Dynamic Range: 10 mA/m to 2 A/m at 1 GHz

(M3 or better device readings fall well below diode

compression point)

Dimensions: Overall length: 330 mm (Tip: 40 mm)

Tip diameter: 6 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 3 mm

E-Field < 10% at 3 GHz (for plane wave)

Interference:



Figure 5-2 H-Field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

Magnetic field sensors are measuring the integral of the H-field across their sensor area surrounded by the loop. They are calibrated in a precise, homogeneous field. When measuring a gradient field, the result will be very close to the field in the center of the loop which is equivalent to the value of a homogeneous field equivalent to the center value. But it will be different from the field at the border of the loop.

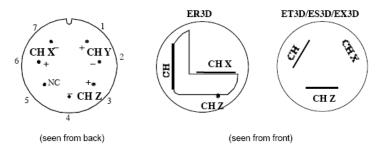
FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Dogo 7 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Page 7 of 75

Consequently, two sensors with different loop diameters - both calibrated ideally - would give different results when measuring from the edge of the probe sensor elements. The behavior for electrically small E-field sensors is equivalent.

The magnetic field loops of the H3D probes are concentric, with the center 3mm from the tip for H3DV6. Their radius is 1.9mm.

The electric field probes have a more irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5mm from the tip, and the element ends are 1.1mm closer to the tip.

Connector Plan



The antistatic shielding inside the probe is connected to the probe connector case.

Instrumentation Chain

Equation 1 Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

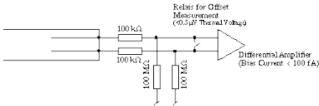
whereby

E_i: electric field in V/m

 u_i : voltage of channel i at the connector in μV $Norm_i$: sensitivity of channel i in $\mu V/(V/m)^2$

ConvF: enhancement factor in liquid (ConvF=1 for Air)
DCP: diode compression point in μV
CF: signal crest factor (peak power/average power)

Conditions of Calibration



Please note:

- a lower input impedance of the amplifier will result in different sensitivity factors Norm, and DCP
- · larger bias currents will cause higher offset

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Dogo 9 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Page 8 of 75

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

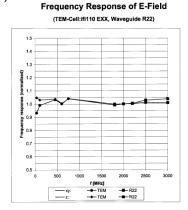


Figure 5-3 E-Field Probe Frequency Response

H-field sensors have a frequency dependent sensitivity which is evaluated for a series of frequencies also visible in the probe calibration certificate. The calibration factors result from a fitting algorithm. The proper conversion is calculated by the DASY4 software depending on the frequency setting in the procedure. See below for H-field frequency response:

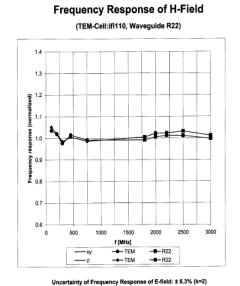


Figure 5-4 H-Field Probe Frequency Response

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:	Page 9 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	rage 9 01 75

Conversion to Peak

Peak is defined as Peak Envelope Power. All raw measurements from the HAC measurement system are RMS values. The DASY4 system incorporates the crest factor of the signal in the computation of the RMS values (See Equation 1). Although the software also has capability to estimate the peak field by applying a square root of crest factor value to the readings, the probe modulation factor was applied manually instead per C63.19 in the measurement tables in this report. The equation to convert the raw measurements in the data tables are:

Peak Field = 20·log (Raw · PMF)

Where:

Peak Field = Peak field (in dBV/m or dBA/m)

Raw = Raw field measurement from the measurement system (in V/m or A/m).

PMF = Probe Modulation Factor (in linear units).

SPEAG Robotic System

E-field and H-field measurements are performed using the DASY4 automated dosimetric assessment system. The DASY4 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Pentium 4 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 5-5SPEAG Robotic System

System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the Gateway Pentium 4 2.53 GHz computer with Windows XP system and RF Measurement Software DASY4 v4.5 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 10 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wit	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

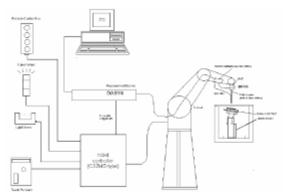


Figure 5-6 SPEAG Robotic System Diagram

DASY4 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$
 with V_i = compensated signal of channel i = input signal of channel i

cf = crest factor of exciting field (DASY parameter) dcp_i = diode compression point (DASY parameter)

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 11 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 110175

(i = x, y, z)

(i = x, y, z)

From the compensated input signals the primary field data for each channel can be evaluated:

E – field
probes :
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

$$H$$
 – field
probes : $H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$

with
$$V_i$$
 = compensated signal of channel i (i = x, y, z)

 $_i$ = sensor sensitivity of channel i $_{\mu}V/(V/m)^2$ for E-field Probes

ConvF = sensitivity enhancement in solution

 a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

 E_i = electric field strength of channel i in V/m H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500 ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500 ms and a probe response time of <5 ms. In the current implementation, DASY4 waits longer than 100 ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 12 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 12 01 75

6. TEST PROCEDURE

I. RF EMISSIONS

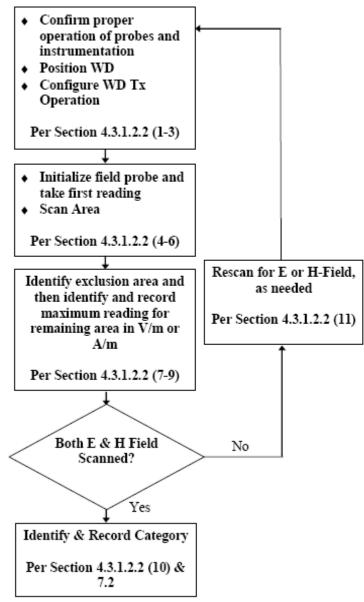


Figure 6-1
WD Near-Field Emissions Flow Chart

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 13 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Faye 13 01 73

Test Setup

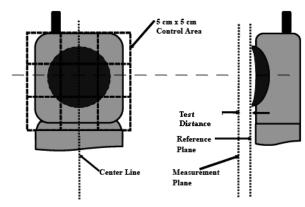


Figure 6-2
E/H-Field Emissions Test Setup Diagram (See Test Photographs for actual WD scan grid overlay)

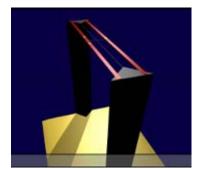


Figure 6-3 HAC Phantom

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- 3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- 4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- 6. The measurement system measured the field strength at the reference location.
- 7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 8. The system performed a drift evaluation by measuring the field at the reference location.
- 9. Steps 1-8 were done for both the E and H-Field measurements.

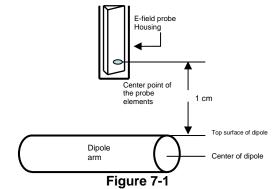
FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 14 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 14 01 75

7. SYSTEM CHECK

I. System Check Parameters

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1 cm probe to dipole separation, which is measured from top surface
 of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is
 shown in the following diagram:



Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device (e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (i.e. - 20dBm) RMS after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

The length of the dipole was scanned with both E-field and H-field probes and the maximum values for each were recorded.

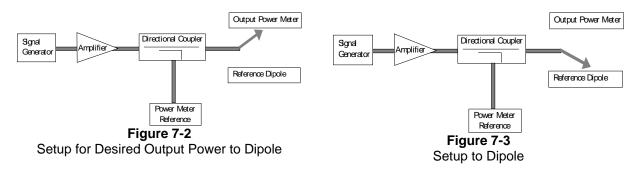
Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 15 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		rage 15 01 75

see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

RF power was recorded using both an average and a peak power reading meter.

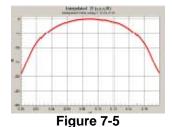


Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 7-3.

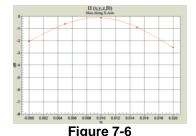
The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:



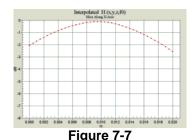
2-D Raw Data from scan along dipole axis



2-D Interpolated points from scan along dipole axis



2-D Raw Data from scan along transverse axis



2-D Interpolated points from scan along transverse axis

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Dogo 16 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Page 16 of 75

III. System Check Results

Validation Results

Frequency (MHz)	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
835	20.0	161.6	164.7	-1.9%
1880	20.0	139.5	136.3	2.3%
Frequency (MHz)	Input Power (dBm)	H-field Result (A/m)	Target Field (A/m)	% Deviation
	Power	Result	Field	, ,

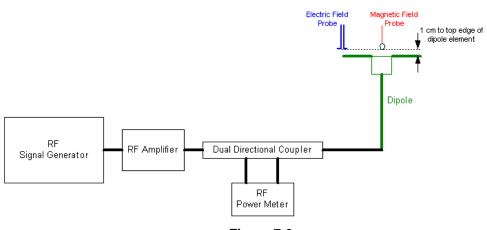


Figure 7-8 System Check Setup

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 17 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 17 0175

8. MODULATION FACTOR

A calibration was made of the modulation response of the probe and its instrumentation chain. This calibration was performed with the field probe, attached to its instrumentation. The response of the probe system to a CW field at the frequency of interest is compared to its response to a modulated signal with equal peak amplitude to that of a CW signal. The field level of the test signals are ensured to be more than 10 dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated reading was applied to the DUT measurements.

All voice modes for this device have been investigated in this section of the report. According to the FCC 3G Measurement Procedures, May 2006 for RF Emissions, variations in peak field and power readings.

This was done using the following procedure:

- 1. The probe was illuminated with a CW signal at the intended measurement frequency and wireless device power.
- 2. The probe was positioned at the field maxima over the dipole antenna (determined after an area scan over the dipole) illuminated with the CW signal.
- 3. The reading of the probe measurement system of the CW signal at the maximum point was recorded.
- 4. Using a Spectrum Analyzer, the modulated signal adjusted with the same peak level of the CW signal was determined.
- 5. The probe measurement system reading was recorded with the modulated signal. The appropriate system crest factors for the modulation type were configured in the software to the system measurements.
- 6. The ratio of the CW reading to modulated signal reading is the probe modulation factor (PMF) for the modulation and field probe combination. This was repeated for 80% AM.
- 7. Steps 1-6 were repeated at all frequency bands and for both E and H field probes.

The modulation factors obtained were applied to readings taken of the actual wireless device, in order to obtain an accurate peak field reading using the formula:

$$Peak = 20 \cdot log (Raw \cdot PMF)$$

This method correlates well with the modulation using the DUT in the alternative substitution method. See below for correlation of signal:

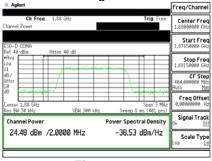


Figure 8-1
Signal Generator Modulated Signal



Figure 8-2
Wireless Device Modulated Signal

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 18 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wi	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Modulation Factors:

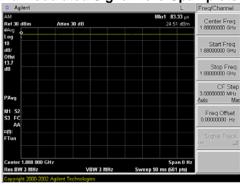
f (MHz)	Peak Power (dBm)	Protocol	E-Field (V/m)	H-Field (A/m)	E-Field Modulation Factor	H-Field Modulation Factor
835	24.5	AM	193.30	0.5751	1.425	1.307
835	24.5	CDMA	295.40	0.9029	0.933	0.833
835	24.5	CW	275.50	0.7517		
1880	24.5	AM	145.50	0.5966	1.452	1.220
1880	24.5	CDMA	212.00	1.0890	0.996	0.668
1880	24.5	CW	211.20	0.7278		

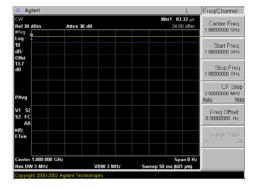
f (MHz)	Protocol	E-Field (V/m)	E-Field Modulation Factor
1880	CDMA / SO3	63.27	2.706
1880	CW	171.21	

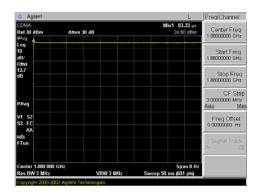
Figure 8-3
Modulation Factors

FCC 3G Note: "CDMA*" represents worst-case mode, while "CDMA/SO3" represents RC1/SO3 mode.

CW and Modulated Signal Zero-Span plots:







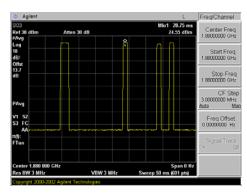


Figure 8-4 Zero-Span Plots

FCC ID: QMNRM-526	PCTEST	HAG	C (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 19 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with-	+BT2.1+EDR	Fage 19 01 75

9. FCC 3G MEASUREMENTS

Sample pre-testing of the various modes were performed at the worst case probe location as part of subset testing justification. See below for measured conducted power for applicable device modes:

I. Conducted RF Output Power Measurements:

Band	Channel	SO2 [dBm]	SO2 [dBm]	SO2 [dBm]	SO55 [dBm]	SO55 [dBm]	SO9 [dBm]	SO9 [dBm]	TDSO SO32 [dBm]	1x EvDO Rev. 0 [dBm]
	F-RC	RC1	RC3	RC4	RC1	RC3	RC2	RC5	RC3	(RTAP)
	Vocoder Rate	Full	Full	Full	Full	Full	Full	Full	N/A	N/A
	1013	24.41	24.32	24.33	24.40	24.32	24.42	24.42	24.42	24.41
Cellular	384	24.50	24.51	24.50	24.50	24.41	24.42	24.51	24.43	24.50
	777	24.32	24.32	24.40	24.41	24.31	24.31	24.42	24.20	24.42
	25	24.31	24.33	24.22	24.22	24.32	24.32	24.32	24.22	24.32
PCS	600	24.33	24.22	24.11	24.33	24.13	24.20	24.13	24.13	24.21
	1175	24.10	23.81	24.03	24.03	23.81	24.04	23.94	24.13	24.03



Figure 9-1
Power Measurement Setup

II. Worst-Case Probe Location Measurements

Below are RC/SO mode investigation results of the device at the worst-case (maximum) field point location. The worst-case RC/SO was used for HAC testing.

Table 9-1
Handset 3G mode variation on RF Emissions, Standard Battery

Mode	Channel	Backlight	RC/SO	Scan Center	Battery	Time Avg. Field (V/m)	Peak Field (dBV/m)	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.4
PCS	1175	off	SO3/RC1	Acoustic	Standard	14.98	32.2	41.0	-8.84	M4	none
PCS	1175	off	SO3/RC3	Acoustic	Standard	41.09	32.2	41.0	-8.76	M4	none
PCS	1175	off	SO3/RC4	Acoustic	Standard	40.85	32.2	41.0	-8.81	M4	none
PCS	1175	off	SO55/RC3	Acoustic	Standard	41.18	32.3	41.0	-8.74	M4	none
PCS	1175	off	SO55/RC1	Acoustic	Standard	40.72	32.2	41.0	-8.84	M4	none
PCS	1175	off	SO2/RC1	Acoustic	Standard	40.59	32.1	41.0	-8.86	M4	none
PCS	1175	off	SO2/RC3	Acoustic	Standard	40.27	32.1	41.0	-8.93	M4	none
PCS	1175	on	SO9/RC2	Acoustic	Standard	40.80	32.2	41.0	-8.82	M4	none
PCS	1175	off	SO9/RC5	Acoustic	Standard	39.36	31.9	41.0	-9.13	M4	none

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 20 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wit	h+BT2.1+EDR	Faye 20 01 75

Table 9-2 Handset 3G mode variation on RF Emissions, Extended Battery

							 				
Mode	Channel	Backlight	RC/SO	Scan Center	Battery	Time Avg. Field (V/m)	Peak Field (dBV/m)	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.4
PCS	1175	off	SO3/RC1	Acoustic	Extended	14.44	27.6	41.0	-13.40	M4	none
PCS	1175	off	SO3/RC3	Acoustic	Extended	32.41	30.2	41.0	-10.82	M4	none
PCS	1175	off	SO3/RC4	Acoustic	Extended	41.15	32.3	41.0	-8.74	M4	none
PCS	1175	off	SO55/RC3	Acoustic	Extended	40.57	32.1	41.0	-8.87	M4	none
PCS	1175	off	SO55/RC1	Acoustic	Extended	40.99	32.2	41.0	-8.78	M4	none
PCS	1175	off	SO2/RC1	Acoustic	Extended	41.09	32.2	41.0	-8.76	M4	none
PCS	1175	off	SO2/RC3	Acoustic	Extended	40.63	32.1	41.0	-8.86	M4	none
PCS	1175	on	SO9/RC2	Acoustic	Extended	37.35	31.4	41.0	-9.59	M4	none
PCS	1175	off	SO9/RC5	Acoustic	Extended	39.27	31.8	41.0	-9.15	M4	none

FCC ID: QMNRM-526	PCTEST	HAC	C (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 21 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with	+BT2.1+EDR	Faye 21 01 75

OVERALL MEASUREMENT SUMMARY 10.

FCC ID:	QMNRM-526
Model:	RM-526
S/N:	A00000016703A2

I. E-FIELD EMISSIONS:

Table 10-1

HAC Data Summary for E-field, Standard Battery

			, Du			,	Otaridai	<u> </u>	/		
Band	Channel	Backlight	RC/SO	Scan Center	Battery	Time Avg. Field (V/m)	Peak Field (dBV/m)	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.4
E-field Em	issions										
CDMA	1013	off	SO3/RC4	Acoustic	Standard	72.48	36.6	51.0	-14.40	M4	none
CDMA	384	off	SO3/RC4	Acoustic	Standard	68.15	36.1	51.0	-14.94	M4	none
CDMA	777	off	SO3/RC4	Acoustic	Standard	75.35	36.9	51.0	-14.06	M4	none
PCS	25	off	SO3/RC4	Acoustic	Standard	38.40	31.7	41.0	-9.35	M4	none
PCS	600	off	SO3/RC4	Acoustic	Standard	42.01	32.4	41.0	-8.57	M4	none
PCS	1175	off	SO3/RC4	Acoustic	Standard	43.23	32.7	41.0	-8.32	M4	none

Table 10-2

HAC Data Summary for E-field, Extended Battery

					<u> </u>						
Band	Channel	Backlight	RC/SO	Scan Center	Battery	Time Avg. Field (V/m)	Peak Field (dBV/m)	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.4
E-field Em	issions										
CDMA	1013	off	SO3/RC4	Acoustic	Extended	70.77	36.4	51.0	-14.61	M4	none
CDMA	384	off	SO3/RC4	Acoustic	Extended	61.10	35.1	51.0	-15.88	M4	none
CDMA	777	off	SO3/RC4	Acoustic	Extended	75.10	36.9	51.0	-14.09	M4	none
PCS	25	off	SO3/RC4	Acoustic	Extended	35.44	31.0	41.0	-10.04	M4	none
PCS	600	off	SO3/RC4	Acoustic	Extended	36.92	31.3	41.0	-9.69	M4	none
PCS	1175	off	SO3/RC4	Acoustic	Extended	40.15	32.0	41.0	-8.96	M4	none

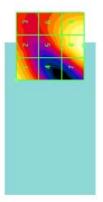


Figure 10-1Sample E-field Scan Overlay (See Test Setup Photographs for actual WD overlay)

Note: Worst-case measurement evaluated for worst-case 1/8 rate gating condition in RC1/SO3; Mute=Yes

FCC ID: QMNRM-526	PCTEST	HAG	C (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 22 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with	+BT2.1+EDR	Faye 22 01 75

FCC ID:	QMNRM-526
Model:	RM-526
S/N:	A00000016703A2

II. H-FIELD EMISSIONS:

Table 10-3
HAC Data Summary for H-field. Standard Battery

		u Dali c i y									
Mode	Channel	Backlight	RC/SO	Scan Center	Battery	Time Avg. Field (A/m)	Peak Field (dBA/m)	FCC Limit (dBA/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.4
H-field Em	issions										
CDMA	1013	off	SO3/RC4	Acoustic	Standard	0.1434	-18.5	0.6	-19.06	M4	none
CDMA	384	off	SO3/RC4	Acoustic	Standard	0.1349	-19.0	0.6	-19.59	M4	none
CDMA	777	off	SO3/RC4	Acoustic	Standard	0.1413	-18.6	0.6	-19.19	M4	none
PCS	25	off	SO3/RC4	Acoustic	Standard	0.0915	-24.3	-9.4	-14.87	M4	none
PCS	600	off	SO3/RC4	Acoustic	Standard	0.1043	-23.1	-9.4	-13.73	M4	none
PCS	1175	off	SO3/RC4	Acoustic	Standard	0.1138	-22.4	-9.4	-12.98	M4	none

Table 10-4 HAC Data Summary for H-field, Extended Battery

Mode	Channel	Backlight	RC/SO	Scan Center	Battery	Time Avg. Field (A/m)	Peak Field (dBA/m)	FCC Limit (dBA/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.4
H-field Em	issions										
CDMA	1013	off	SO3/RC4	Acoustic	Extended	0.1332	-19.1	0.6	-19.70	M4	none
CDMA	384	off	SO3/RC4	Acoustic	Extended	0.1326	-19.1	0.6	-19.74	M4	none
CDMA	777	off	SO3/RC4	Acoustic	Extended	0.1352	-19.0	0.6	-19.57	M4	none
PCS	25	off	SO3/RC4	Acoustic	Extended	0.0945	-24.0	-9.4	-14.59	M4	none
PCS	600	off	SO3/RC4	Acoustic	Extended	0.0974	-23.7	-9.4	-14.33	M4	none
PCS	1175	off	SO3/RC4	Acoustic	Extended	0.0950	-24.0	-9.4	-14.55	M4	none



Figure 10-2
Sample H-field Scan Overlay
(See Test Setup Photographs for actual WD overlay)

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 23 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 23 01 75

FCC ID:	QMNRM-526
Model:	RM-526
S/N:	A00000016703A2

III. Worst-case Configuration Evaluation

Table 10-5
Peak Reading 360° Probe Rotation at Azimuth axis

Mode	Channel	Backlight	RC/SO	Scan Center	Battery	Time Avg. Field (V/m)	Peak Field (dBV/m)	FCC Limit (dBV/m)	FCC MARGIN (dB)
Probe Rotat	tion at Worst-	case		-					
PCS	1175	off	SO3/RC4	Acoustic	Standard	43.26	32.7	41.0	-8.31

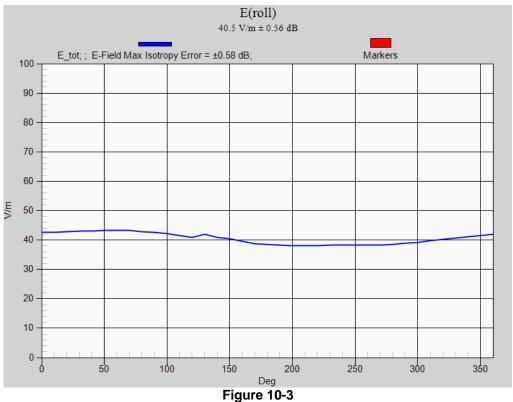


Figure 10-3
Worst-Case Probe Rotation about Azimuth axis

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 24 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with-	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

^{*} Note: Location of probe rotation is shown in Figure 10-1 or Figure 10-2

11. EQUIPMENT LIST

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	8648D	(9kHz-4GHz) Signal Generator	10/11/2007	Biennial	10/11/2009	3613A00315
Agilent	E4407B	ESA Spectrum Analyzer	3/24/2009	Annual	3/24/2010	US39210313
Agilent	E4432B	ESG-D Series Signal Generator	8/18/2008	Annual	8/18/2009	US40053896
Agilent	E5515C	Wireless Communications Test Set	6/8/2007	Biennial	6/8/2009	GB46110872
Agilent	E5515C	Wireless Communications Test Set	6/8/2007	Biennial	6/8/2009	GB46310798
Agilent	E5515C	Wireless Communications Test Set	9/10/2008	Biennial	9/10/2010	GB41450275
Rohde & Schwarz	CMU200	Base Station Simulator	5/29/2008	Annual	5/29/2009	836371/0079
Rohde & Schwarz	CMU200	Base Station Simulator	7/23/2008	Annual	7/23/2009	109892
Rohde & Schwarz	NRVD	Dual Channel Power Meter	8/20/2008	Biennial	8/20/2010	101695
Rohde & Schwarz	NRVS	Single Channel Power Meter	7/3/2007	Biennial	7/3/2009	835360/0079
Rohde & Schwarz	NRV-Z32	Peak Power Sensor (100uW-2W)	12/5/2008	Biennial	12/5/2010	100155
Rohde & Schwarz	NRV-Z33	Peak Power Sensor (1mW-20W)	12/5/2008	Biennial	12/5/2010	100004
Rohde & Schwarz	NRV-Z53	Power Sensor	7/3/2007	Biennial	7/3/2009	846076/0007
SPEAG	CD1880V3	Freespace 1880 MHz Dipole	1/21/2009	Biennial	1/21/2011	1002
SPEAG	CD1880V3	Freespace 1880 MHz Dipole	3/11/2008	Biennial	3/11/2010	1064
SPEAG	CD2450V3	Freespace 2450 MHz Dipole	7/17/2008	Biennial	7/17/2010	1062
SPEAG	CD835V3	Freespace 835 MHz Dipole	7/16/2008	Biennial	7/16/2010	1082
SPEAG	CD835V3	Freespace 835 MHz Dipole	1/14/2009	Biennial	1/14/2011	1003
SPEAG	DAE3	Dasy Data Acquisition Electronics	10/17/2008	Annual	10/17/2009	455
SPEAG	DAE4	Dasy Data Acquisition Electronics	6/26/2008	Annual	6/26/2009	704
SPEAG	DAE4	Dasy Data Acquisition Electronics	8/25/2008	Annual	8/25/2009	665
SPEAG	DAE4	Dasy Data Acquisition Electronics	1/21/2009	Annual	1/21/2010	649
SPEAG	ER3DV6	Freespace E-field Probe	7/17/2008	Annual	7/17/2009	2353
SPEAG	ER3DV6	Freespace E-field Probe	10/15/2008	Annual	10/15/2009	2335
SPEAG	ER3DV6	Freespace E-field Probe	1/16/2009	Annual	1/16/2010	2332
SPEAG	H3DV6	Freespace H-field Probe	7/17/2008	Annual	7/17/2009	6207
SPEAG	H3DV6	Freespace H-field Probe	10/15/2008	Annual	10/15/2009	6170
SPEAG	H3DV6	Freespace H-field Probe	1/19/2009	Annual	1/19/2010	6180
SPEAG	CD700V3	Freespace 700MHz Dipole	7/17/2008	Biennial	7/17/2010	1003
SPEAG	DAE4	Dasy Data Acquisition Electronics	7/30/2008	Annual	7/30/2009	859
SPEAG	ER3DV6	Freespace E-field Probe	9/5/2008	Annual	9/5/2009	2447
SPEAG	H3DV6	Freespace H-field Probe	9/5/2008	Annual	9/5/2009	6276

Table 11-1 Equipment List

*Calibration traceable to the National Institute of Standards and Technology (NIST).

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 25 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 25 01 75

12. MEASUREMENT UNCERTAINTY

Wirele	Wireless Communications Device Near-Field Measurement Uncertainty Estimation							
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Ci (H)	Unc. (dB)	Notes/Comments
Measurement System								
RF System Reflections	0.50	Tolerance	N	1.00	1	1	0.50	Refl. < -20 dB
Field Probe Calibration	0.21	Tolerance	N	1.00	1	1	0.21	
Field Probe Isotropy	0.01	Tolerance	N	1.00	1	1	0.01	
Field Probe Frequency Response	0.135	Tolerance	N	1.00	1	1	0.14	
Field Probe Linearity	0.013	Tolerance	N	1.00	1	1	0.01	
Probe Modulation Factor	0.270	Accuracy	R	1.73	1	1	0.16	
Boundary Effects	0.105	Accuracy	R	1.73	1	1	0.06	*
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.670	0.12	*
Probe Positioner	0.050	Accuracy	R	1.73	1	0.670	0.03	*
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	1	0.03	*
Resolution to 2mm error	0.210	Tolerance	N	1.00	1	1	0.21	
System Detection Limit	0.05	Tolerance	R	1.73	1	1	0.03	*
Readout Electronics	0.015	Tolerance	N	1.00	1	1	0.02	*
Integration Time	0.11	Tolerance	R	1.73	1	1	0.06	*
Response Time	0.033	Tolerance	R	1.73	1	1	0.02	*
Phantom Thickness	0.10	Tolerance	R	1.73	1	1	0.06	*
System Repeatability (Field x 2=power)	0.17	Tolerance	N	1.00	1	1	0.17	
Test Sample Related								
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	1	0.12	*
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	1	0.03	*
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	1	0.06	*
Power Drift	0.21	Tolerance	R	1.73	1	1	0.12	
Combined Standard Uncertainty (k=1)							0.66	16.5%
Expanded Uncertainty [95% confidence] (k	(=2)						1.33	32.3%
Expanded Uncertainty [95% confidence	1 on Field						0.66	16.2%

Table 12-1 Uncertainty Estimation Table

Notes:

- Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All
 equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81
 and NIST Tech Note 1297 and UKAS M3003.
- 2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:	EUT Type:	
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

13. TEST DATA

See following Attached Pages for Test Data.

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 27 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	



DUT: CD835V3 - SN1003

Type: CD835V3 Serial: 1003

Communication System: CW; Frequency: 835 MHz;

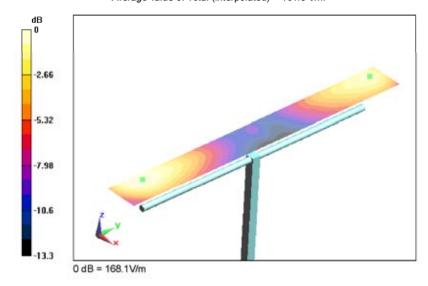
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ER3DV6 SN2447; Calibrated: 9/5/2008
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

835 MHz / 100mW HAC Dipole Validation, Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm Probe Modulation Factor = 1 Reference Value = 89.3 V/m; Power Drift = -0.011 dB Average value of Total (interpolated) = 161.6 V/m



FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 28 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wit	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Date: 4/2/2009



DUT: CD835V3 - SN1003

Type: CD835V3 Serial: 1003

Communication System: CW; Frequency: 835 MHz;

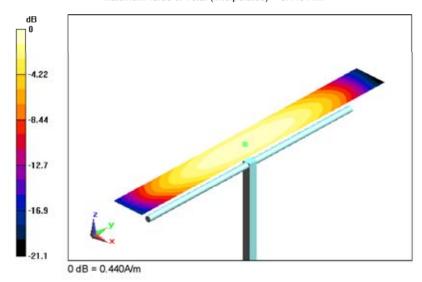
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: H3DV6 SN6276; Calibrated: 9/5/2008
- · Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- . Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- . Measurement SW: DASY5, V5.0 Build 125;

835 MHz / 100 mW HAC Validation, Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm
Probe Modulation Factor = 1
Reference Value = 0.467 A/m; Power Drift = -0.032 dB
Maximum value of Total (interpolated) = 0.440 A/m



FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 29 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Date: 4/2/2009



DUT: CD1880V3 - SN1002

Type: CD1880V3 Serial: 1002

Communication System: CW; Frequency: 1880 MHz;

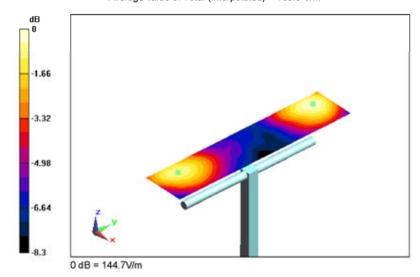
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ER3DV6 SN2447; Calibrated: 9/5/2008
- · Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

1880 MHz / 100mW HAC Dipole Validation, Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm Probe Modulation Factor = 1 Reference Value = 149.1 V/m; Power Drift = 0.012 dB Average value of Total (interpolated) = 139.5 V/m



FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 30 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+B	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Date: 4/2/2009



DUT: CD1880V3 - SN1002

Type: CD1880V3 Serial: 1002

Communication System: CW; Frequency: 1880 MHz;

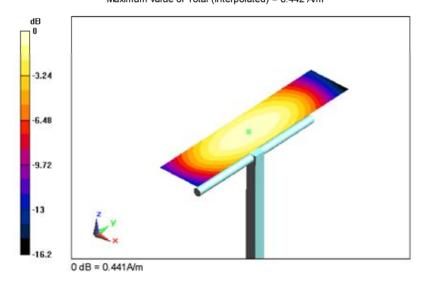
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: H3DV6 SN6276; Calibrated: 9/5/2008
- · Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

1880 MHz / 100 mW HAC Validation, Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm
Probe Modulation Factor = 1
Reference Value = 0.466 A/m; Power Drift = -0.017 dB
Maximum value of Total (interpolated) = 0.442 A/m



FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 31 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+B	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Date: 4/6/2009



DUT: RM-526

Type: Dual-Band CDMA/EVDO Phone with+BT2.1+EDR Serial: A00000016703A2 Backlight off Duty Cycle: 1:1

Communication System: Cell CDMA; Frequency: 848.31 MHz;

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

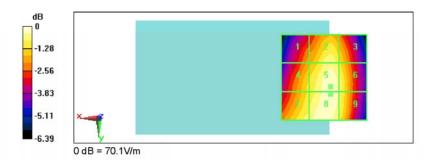
- Probe: ER3DV6 SN2447; Calibrated: 9/5/2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

Cell. CDMA High Channel/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 70.1 V/m Probe Modulation Factor = 0.933 Reference Value = 95.6 V/m; Power Drift = -0.117 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
56.8 M4	65.8 M4	62 M4
Grid 4	Grid 5	Grid 6
61.8 M4	69.9 M4	66 M4
Grid 7	Grid 8	Grid 9
66.5 M4	70.1 M4	65.9 M4



FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 32 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Date: 4/6/2009



DUT: RM-526

Type: Dual-Band CDMA'EVDO Phone with+BT2.1+EDR Serial: A00000016703A2 Backlight off Duty Cycle: 1:1

Communication System: Cellular CDMA; Frequency: 848.31 MHz;

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

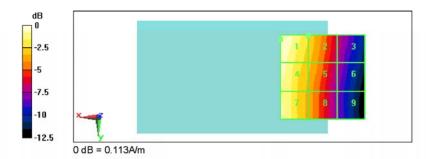
- Probe: H3DV6 SN6276; Calibrated: 9/5/2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

Cell. CDMA High Channel/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.113 A/m Probe Modulation Factor = 0.833 Reference Value = 0.073 A/m; Power Drift = 0.379 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.113 M4	0.084 M4	0.053 M4
Grid 4	Grid 5	Grid 6
0.108 M4	0.080 M4	0.050 M4
Grid 7	Grid 8	Grid 9



FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 33 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Date: 4/7/2009



DUT: RM-526

Type: Dual-Band CDMA/EVDO Phone with+BT2:1+EDR Serial: A00000016703A2 Backlight off Duty Cycle: 1:1

Communication System: PCS CDMA; Frequency: 1908.75 MHz;

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

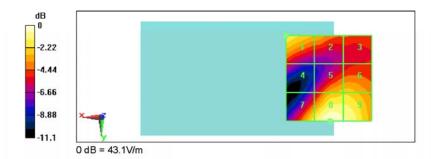
- Probe: ER3DV6 SN2447; Calibrated: 9/5/2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

PCS CDMA High Channel/Hearing Aid Compatibility Test, Std Battery (101x101x1):

Measurement grid: dx=5mm, dy=5mm
Maximum value of peak Total field = 43.1 V/m
Probe Modulation Factor = 0.996
Reference Value = 24.9 V/m; Power Drift = 0.274 dB
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in $\ensuremath{\mathrm{V/m}}$

Grid 1	Grid 2	Grid 3
36.7 M4	30.7 M4	26.4 M4
Grid 4	Grid 5	Grid 6
23.8 M4	32.4 M4	32.6 M4
Grid 7	Grid 8	Grid 9
35.6 M4	43.1 M4	40.8 M4



FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 34 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wit	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Date: 4/6/2009



DUT: RM-526

Type: Dual-Band CDMA/EVDO Phone with+BT2.1+EDR Serial: A00000016703A2 Backlight off Duty Cycle: 1:1

Communication System: PCS CDMA; Frequency: 1880 MHz;

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

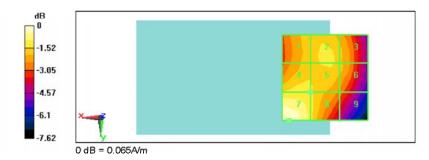
- Probe: H3DV6 SN6276; Calibrated: 9/5/2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn859; Calibrated: 7/30/2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY5, V5.0 Build 125;

PCS CDMA Mid Channel/Hearing Aid Compatibility Test (101x101x1):

Measurement grid: dx=5mm, dy=5mm
Maximum value of peak Total field = 0.065 A/m
Probe Modulation Factor = 0.668
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 0.086 A/m; Power Drift = -0.188 dB
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.054 M4	0.055 M4	0.053 M4
Grid 4	Grid 5	Grid 6
0.056 M4	0.055 M4	0.053 M4
Grid 7	Grid 8	Grid 9



FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 35 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wit	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

14. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 36 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

S

С

Certificate No: ER3-2447_Sep08 **CALIBRATION CERTIFICATE** ER3DV6 - SN:2447 Object QA CAL-02.v5 Calibration procedure(s) Calibration procedure for E-field probes optimized for close near field evaluations in air September 5, 2008 Calibration date: Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). ments and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Cal Date (Certificate No.) Scheduled Calibration Primary Standards Power meter E44198 GB41293874 1-Apr-08 (No. 217-00788) Apr-09 Power sensor E4412A MY41495277 1-Apr-08 (No. 217-00788) Apr-09 Apr-09 Power sensor E4412A MY41498087 1-Apr-08 (No. 217-00788) Reference 3 dB Attenuator SN: S5054 (3c) 1-Jul-08 (No. 217-00865) Jul-09 Apr-09 31-Mar-08 (No. 217-00787) Reference 20 dB Attenuator SN: S5086 (20b) Jul-09 SN: S5129 (30b) 1-Jul-08 (No. 217-00866) Reference 30 dB Attenuator 2-Oct-07 (No. ER3-2328_Oct07) Oct-08 Reference Probe ER3DV6 SN: 2328 5-Dec-07 (No. DAE4-789_Dec07) Dec-08 SN: 789 DAE4 Scheduled Check Check Date (in house) 1D# Secondary Standards US3642U01700 4-Aug-99 (in house check Oct-07) In house check: Oct-09 RF generator HP 8648C Network Analyzer HP 8753E US37390585 18-Oct-01 (in house check Oct-07) In house check: Oct-08 Function Name Technical Manager Katja Pokovic Calibrated by: Niels Kuster Quality Manager Approved by: issued: September 15, 2008 This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: ER3-2447_Sep08 Page 1 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 37 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 3/ 01/3

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura

Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point Polarization φ rotation around probe axis

Polarization ϑ ϑ rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot

coordinate system

Calibration is Performed According to the Following Standards:

 a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization θ = 0 for XY sensors and θ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: ER3-2447_Sep08 Page 2 of 9

FCC ID: QMNRM-526HAC (RF EMISSIONS) TEST REPORTNOKIAReviewed by:
Quality ManagerHAC Filename:
0903180521.QMNTest Dates:
4/6/2009EUT Type:
Dual-Band CDMA/EVDO Phone with+BT2.1+EDRPage 38 of 75

September 5, 2008

Probe ER3DV6

SN:2447

Manufactured: Calibrated:

January 22, 2008 September 5, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: ER3-2447_Sep08

Page 3 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 39 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 33 01 73

DASY - Parameters of Probe: ER3DV6 SN:2447

Sensitivity in Free Space [µV/(V/m)²]	Diode Compression

NormX	1.55 ± 10.1 % (k=2)	DCP X	96 mV
NormY	1.63 ± 10.1 % (k=2)	DCP Y	94 mV
NormZ	1.88 ± 10.1 % (k=2)	DCP Z	98 mV

Frequency Correction

X	0.0
Υ	0.0
Z	0.0

Sensor Offset (Probe Tip to Sensor Center)

X 2.5 mm Y 2.5 mm Z 2.5 mm

Connector Angle 22 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ER3-2447_Sep08

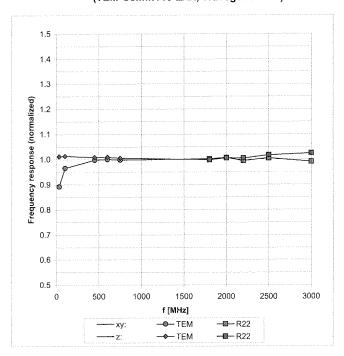
Page 4 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 40 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

^A numerical linearization parameter: uncertainty not required

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



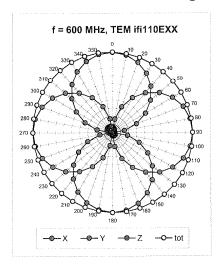
Uncertainty of Frequency Response of E-field: $\pm~6.3\%$ (k=2)

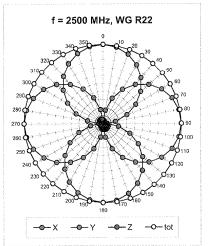
Certificate No: ER3-2447_Sep08

Page 5 of 9

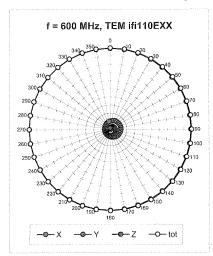
FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT NOKIA		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 41 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Faye 41 01 75

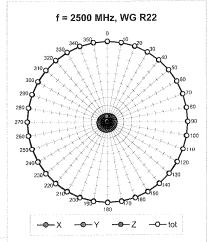
Receiving Pattern (ϕ), θ = 0°





Receiving Pattern (ϕ), ϑ = 90°



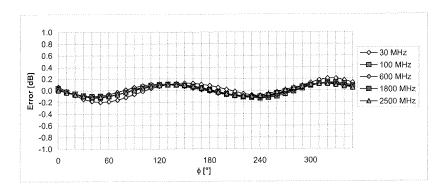


Certificate No: ER3-2447_Sep08

Page 6 of 9

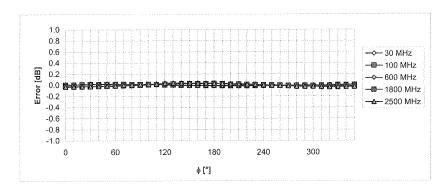
FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT NOK		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Dogo 42 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Page 42 of 75

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

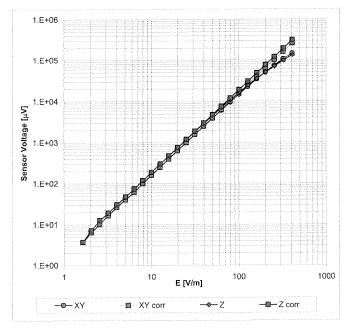
Certificate No: ER3-2447_Sep08

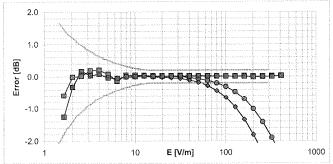
Page 7 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 43 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Faye 43 01 73

September 5, 2008

Dynamic Range f(E-field) (Waveguide R22, f = 1800 MHz)





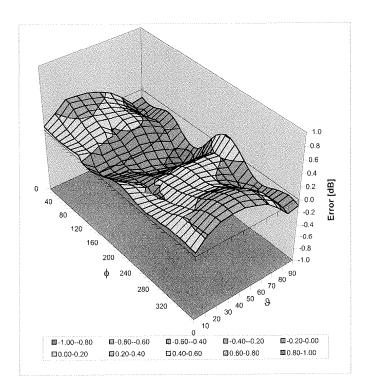
Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: ER3-2447_Sep08

Page 8 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 44 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Faye 44 01 75

Deviation from Isotropy in Air Error (ϕ , ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ER3-2447_Sep08

Page 9 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 45 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wit	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

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Client

PC Test

Certificate No: H3-6276_Sep08

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE H3DV6 - SN:6276 Object QA CAL-03.v5 Calibration procedure(s) Calibration procedure for H-field probes optimized for close near field evaluations in air September 5, 2008 Calibration date: Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Scheduled Calibration Primary Standards 1D # Cal Date (Certificate No.) 1-Apr-08 (No. 217-00788) Apr-09 GB41293874 Power meter E4419B 1-Apr-08 (No. 217-00788) Apr-09 Power sensor E4412A MY41495277 Арг-09 1-Apr-08 (No. 217-00788) Power sensor E4412A MY41498087 Jul-09 1-Jul-08 (No. 217-00865) Reference 3 dB Attenuator SN: S5054 (3c) Apr-09 31-Mar-08 (No. 217-00787) Reference 20 dB Attenuator SN: S5086 (20b) Jul-09 1-Jul-08 (No. 217-00866) Reference 30 dB Attenuator SN: S5129 (30b) 2-Oct-07 (No. H3-6182_Oct07) Oct-08 Reference Probe H3DV6 SN: 6182 SN: 789 5-Dec-07 (No. DAE4-789_Dec07) Dec-08 Scheduled Check Check Date (in house) Secondary Standards In house check: Oct-09 RF generator HP 8648C US3642U01700 4-Aug-99 (in house check Oct-07) In house check: Oct-08 Network Analyzer HP 8753E US37390585 18-Oct-01 (in house check Oct-07) Function Signature Name Katja Pokovic Technical Manager Calibrated by: Quality Manager Approved by: Niels Kuster Issued: September 15, 2008 This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: H3-6276_Sep08

Page 1 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 46 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with-	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

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Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space
DCP diode compression point
Polarization φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot

coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.

Methods Applied and Interpretation of Parameters:

- X,Y,Z a0a1a2: Assessed for E-field polarization θ = 90 for XY sensors and θ = 0 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X,Y,Z(f)_a0a1a2= X,Y,Z_a0a1a2* frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X_a0a1a2 (no uncertainty required).

Certificate No: H3-6276_Sep08

Page 2 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 47 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Faye 47 01 75

H3DV6 SN:6276 September 5, 2008

Probe H3DV6

SN:6276

Manufactured: Calibrated:

November 30, 2007 September 5, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: H3-6276_Sep08

Page 3 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:	Page 48 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	Faye 40 01 75

September 5, 2008

H3DV6 SN:6276

DASY - Parameters of Probe: H3DV6 SN:6276

Sensitivity in Free Space [A/m / $\sqrt{(\mu V)}$]

	a0 a	11	a2	
Χ	2.517E-03	-1.593E-4	-2.344E-5	\pm 5.1 % (k=2)
Υ	2.462E-03	-5.309E-5	2.858E-6	± 5.1 % (k=2)
7	2.961E-03	-1.712E-4	2.929E-6	± 5.1 % (k=2)

Diode Compression¹

DCP X	82 mV
DCP Y	90 mV
DCP Z	82 mV

Sensor Offset (Probe Tip to Sensor Center)

Χ	3.0 mm
Υ	3.0 mm
Z	3.0 mm

Connector Angle 82 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: H3-6276_Sep08

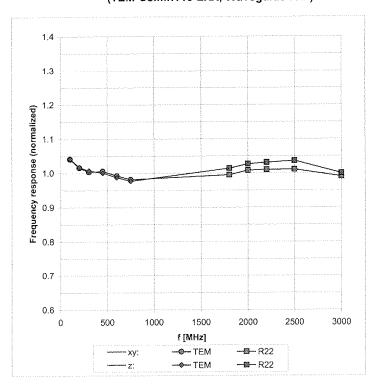
Page 4 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 49 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Faye 43 01 75

¹ numerical linearization parameter: uncertainty not required

Frequency Response of H-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)



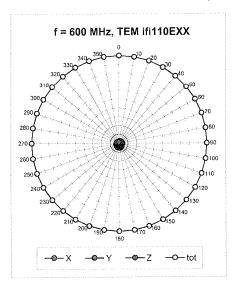
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

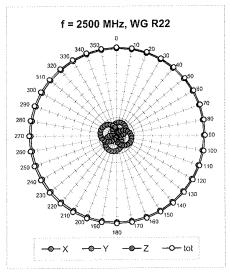
Certificate No: H3-6276_Sep08

Page 5 of 9

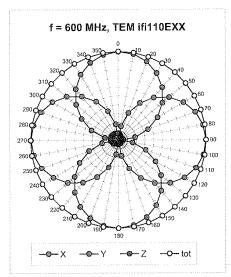
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HAC Filename:	Test Dates:	EUT Type:		Page 50 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

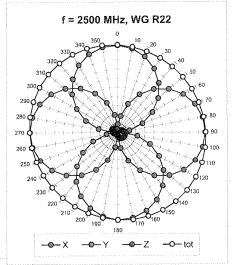
Receiving Pattern (ϕ), ϑ = 90°





Receiving Pattern (ϕ), θ = 0°



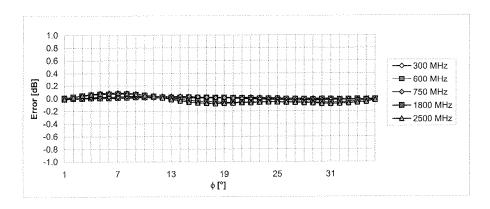


Certificate No: H3-6276_Sep08

Page 6 of 9

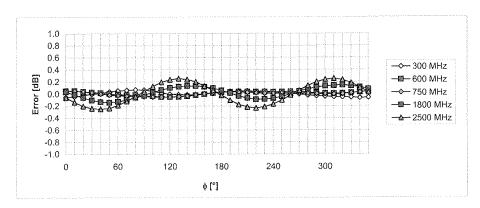
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HAC Filename:	Test Dates:	EUT Type:		Page 51 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), ϑ = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

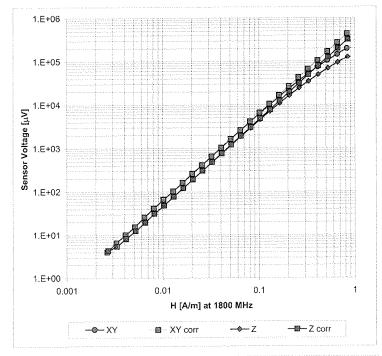
Certificate No: H3-6276_Sep08

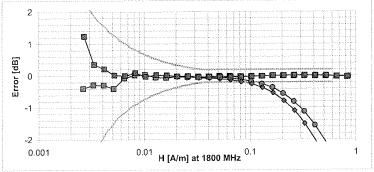
Page 7 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 52 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 32 01 75

Dynamic Range f(H-field)

(Waveguide R22, f = 1800 MHz)





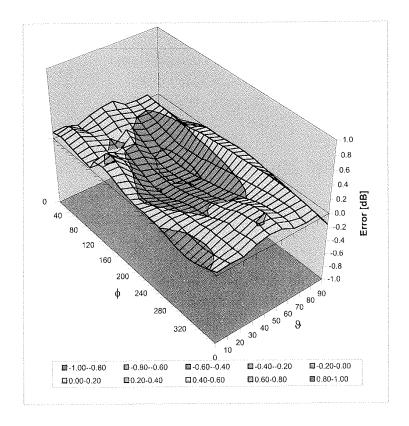
Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: H3-6276_Sep08

Page 8 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 53 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Deviation from Isotropy in Air Error (ϕ , ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: H3-6276_Sep08

Page 9 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 54 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Faye 54 01 75

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Accreditation No.: SCS 108

S

C

Client

PC Test

Certificate No: CD835V3-1003_Jan09

CALIBRATION CERTIFICATE Object CD835V3 - SN: 1003 QA CAL-20.v4 Calibration procedure(s) Calibration procedure for dipoles in air Calibration date: January 14, 2009 Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Scheduled Calibration ID# Cal Date (Certificate No.) Primary Standards Power meter EPM-442A GB37480704 08-Oct-08 (No. 217-00898) Oct-09 US37292783 08-Oct-08 (No. 217-00898) Oct-09 Power sensor HP 8481A Probe ER3DV6 SN: 2336 22-Dec-08 (No. ER3-2336_Dec08) Dec-09 SN: 6065 22-Dec-08 (No. H3-6065 -Dec08) Dec-09 Probe H3DV6 DAE4 SN: 781 03-Oct-08 (No. DAE4-781_Oct08) Oct-09 Secondary Standards ID# Check Date (in house) Scheduled Check GB42420191 n house check: Oct-09 Power meter EPM-4419B 11-May-05 (in house check Oct-07) Power sensor HP 8482A US37295597 11-May-05 (in house check Oct-07) n house check: Oct-09 Power sensor HP 8482H 3318A09450 08-Jan-02 (in house check Oct-07) n house check: Oct-09 Network Analyzer HP 8753E US37390585 18-Oct-01 (in house check Oct-08) in house check: Oct-09 MY 41310391 03-Nov-04 (in house check Oct-07) n house check: Oct-09 RF generator E4433B Name Function Calibrated by: Claudio Leubler Laboratory Technician Fin Bombolt Technical Director Approved by: Issued: January 15, 2009 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD835V3-1003_Jan09

Page 1 of 6

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 55 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurlch, Switzerland





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Accreditation No.: SCS 108

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References

[1] ANSI-C63.19-2006

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms, x-axis is normal to the other
 axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to
 be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate.
 All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under tost is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipoie is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a tine. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check, ob. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HF 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field prope with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field
 scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field
 value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the
 dipole surface at the feed point.

Certificate No: CD635V3-1003 Jan09 Page 2 of 6

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 56 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with-	+BT2.1+EDR	Fage 30 01 75

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B71
DASY PP Version	SEMCAD	V1.8 D184
Phantoni	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 180 mm
Frequency	835 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10	mm above dipole surface	condition	interpolated maximum
Maximum a	rreasured	100 mW forward power	0.440 A/m
Uncertainty f	or H-field measurement 8.2% (k=2)		

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end-	100 mW forward power	164.5 V/m
Maximum measured above low end	100 mW forward power	161.9 V/m
Averaged maximum above arm	100 mW forward power	163.2 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	; 17.2 dB	(43.3 – j11.0) Ohm
835 MHz	26.4 dB	(51.5 + J4.7) Ohm
900 MHz	: 15.2 dB	(58.7 – j17.1) Ohm
950 MHz	24.9 dB	i (48.0 j5.3) Chm
960 MHz	; 17.8 dB	(55.5 - j12.6) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overneating, check the impedance characteristics to ensure that the internal matching network is not affected.

Page 3 of 6

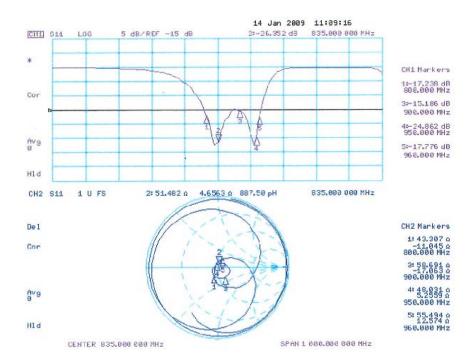
After long term use with 40W radiated power, only a slight warming of the cipole near the feedpoint can be measured.

Certificate Not CD835V3-1003_Jan09

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 57 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	+BT2.1+EDR	Fage 37 01 73

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



Certificate No: CD835V3-1003_Jan09

Page 4 of 6

FCC ID: QMNRM-526	PCTEST	НАС	(RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:		EUT Type:		Page 58 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with	+BT2.1+EDR	rage 30 01 73

3.3.2 DASY4 H-field Result

Date/Time: 13.01.2009 12:02:15

Test Laboratory: SPEAG Lab 2

H_CD835_1003_090113

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1003 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.440 A/m

Probe Modulation Factor = 1.00

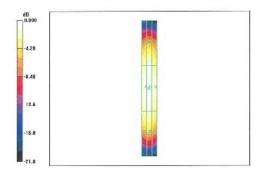
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.467 A/m; Power Drift = -0.015 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.377 M4	0.394 M4	0.367 M4
Grid 4	Grid 5	Grid 6
0.422 M4	0.440 M4	0.410 M4
Grid 7	Grid 8	Grid 9
0.374 M4	0.391 M4	0.364 M4



0 dB = 0.440 A/m

Certificate No: CD835V3-1003_Jan09

Page 5 of 6

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 59 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	n+BT2.1+EDR	Fage 59 01 75

3.3.3 DASY4 E-field Result

Date/Time: 14.01.2009 16:47:01

Test Laboratory: SPEAG Lab 2

E_CD835_1003_090114

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1003 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 164.5 V/m

Probe Modulation Factor = 1.00

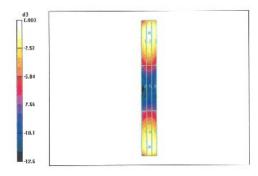
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 105.1 V/m; Power Drift = -0.006 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
157.6 M4	164.5 M4	161.9 M4
Grid 4	Grid 5	Grid 6
84.8 M4	87.7 M4	85.5 M4
Grid 7	Grid 8	Grid 9
154.4 M4	161.9 M4	158.9 M4



0 dB = 164.5 V/m

Certificate No: CD835V3-1003_Jan09

Page 6 of 6

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT	NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 60 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	+BT2.1+EDR	Fage 00 01 75

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura **Swiss Calibration Service**

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

C

Client PC Test

Certificate No: CD1880V3-1002_Jan09

Object	CD1880V3 - SN	ł: 1002	DA PERMIT
Calibration procedure(s)	QA CAL-20.v4 Calibration prod	edure for dipoles in air	
Calibration date:	January 21, 200	09	
Condition of the calibrated item	In Tolerance		OTHER DESIGNATION
Calibration Equipment used (M&	TE Gladarior dalleration)		25.5
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00698)	Oct-09
Power meter EPM-442A Power sensor HP 8481A	GB37480704 US37292783	08-Oct-08 (No. 217-00698) 08-Oct-08 (No. 217-00698)	Oct-09 Oct-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6	GB37480704 US37292783 SN: 2336	08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08)	Oct-09 Oct-09 Dec-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6	GB37480704 US37292783	08-Oct-08 (No. 217-00698) 08-Oct-08 (No. 217-00698)	Oct-09 Oct-09
Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	GB37480704 US37292783 SN: 2336 SN: 6065	08-Oct-08 (No. 217-00698) 08-Oct-08 (No. 217-00698) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6085Dec08) 03-Oct-08 (No. DAE4-781_Oct08)	Oct-09 Oct-09 Dec-09 Dec-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards	GB37480704 US37292783 SN: 2336 SN: 6065 SN 781	08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6085Dec08)	Oct-09 Oct-09 Dec-09 Dec-09 Oct-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter EPM-4419B	GB37480704 US37292783 SN: 2336 SN: 6065 SN 781	08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6065Dec08) 03-Oct-08 (No. DAE4-781_Oct08) Check Date (in house)	Oct-09 Oct-09 Dec-09 Dec-09 Oct-09 Oct-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter EPM-4419B Power sensor HP 8482A	GB37480704 US37292783 SN: 2336 SN: 6065 SN 781	08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6085Dec08) 03-Oct-08 (No. DAE4-781_Oct08) Check Date (in house) 11-May-05 (in house check Oct-07)	Oct-09 Oct-09 Dec-09 Dec-09 Oct-09 Oct-09 Scheduled Check In house check: Oct-09 In house check: Oct-09 In house check: Oct-09 In house check: Oct-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter EPM-4419B Power sensor HP 8482A Power sensor HP 8482H Network Analyzer HP 8753E	GB37480704 US37292763 SN: 2336 SN: 6065 SN 781 ID # GB42420191 US37295597 3318A09450 US37390585	08-Oct-08 (No. 217-00698) 08-Oct-08 (No. 217-00698) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6085Dec08) 03-Oct-08 (No. DAE4-781_Oct08) Check Date (in house) 11-May-05 (in house check Oct-07) 11-May-05 (in house check Oct-07) 18-Oct-01 (in house check Oct-07)	Oct-09 Oct-09 Dec-09 Dec-09 Oct-09 Oct-09 Scheduled Check In house check: Oct-09 In house check: Oct-09 In house check: Oct-09 In house check: Oct-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter EPM-4419B Power sensor HP 8482A Power sensor HP 8482H Network Analyzer HP 8753E	GB37480704 US37292783 SN: 2336 SN: 6065 SN 781 ID # GB42420191 US37295597 3318A09450	08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6085Dec08) 03-Oct-08 (No. DAE4-781_Oct08) Check Date (in house) 11-May-05 (in house check Oct-07) 11-May-05 (in house check Oct-07) 08-Jan-02 (in house check Oct-07)	Oct-09 Oct-09 Dec-09 Dec-09 Oct-09 Scheduled Check In house check: Oct-09 In house check: Oct-09 In house check: Oct-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6	GB37480704 US37292763 SN: 2336 SN: 6065 SN 781 ID # GB42420191 US37295597 3318A09450 US37390585	08-Oct-08 (No. 217-00698) 08-Oct-08 (No. 217-00698) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6085Dec08) 03-Oct-08 (No. DAE4-781_Oct08) Check Date (in house) 11-May-05 (in house check Oct-07) 11-May-05 (in house check Oct-07) 18-Oct-01 (in house check Oct-07)	Oct-09 Oct-09 Dec-09 Dec-09 Oct-09 Oct-09 Scheduled Check In house check: Oct-09
Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter EPM-4419B Power sensor HP 8482A Power sensor HP 8482H Network Analyzer HP 8753E	GB37480704 US37292783 SN: 2336 SN: 6065 SN 781 ID # GB42420191 US37296597 3318A09450 US37390585 MY 41310391	08-Oct-08 (No. 217-00898) 08-Oct-08 (No. 217-00898) 22-Dec-08 (No. ER3-2336_Dec08) 22-Dec-08 (No. H3-6085Dec08) 03-Oct-08 (No. DAE4-781_Oct08) Check Date (in house) 11-May-05 (in house check Oct-07) 11-May-05 (in house check Oct-07) 08-Jan-02 (in house check Oct-07) 18-Oct-01 (in house check Oct-08) 22-Nov-04 (in house check Oct-07)	Oct-09 Oct-09 Dec-09 Dec-09 Oct-09 Oct-09 Scheduled Check In house check: Oct-09

Certificate No: CD1880V3-1002_Jan09

Page 1 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager		
HAC Filename:	Test Dates:		EUT Type:		Page 61 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Page 61 01 75

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage C Servizio svizzero di taratura S **Swiss Calibration Service**

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

References

ANSI-C63.19-2006 [1]

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E- field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

Certificate No: CD1880V3-1002_Jan09 Page 2 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 62 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

1. Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B71
DASY PP Version	SEMCAD	V1.8 B184
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2. Maximum Field values

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.460 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW forward power	137.6 V/m	
Maximum measured above low end	100 mW forward power	136.8 V/m	
Averaged maximum above arm	100 mW forward power	137.2 V/m	

Uncertainty for E-field measurement: 12.8% (k=2)

3. Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
1710 MHz	28.7 dB	(49.6 + j3.6) Ohm
1880 MHz	17.2 dB	(47.0 + j13.2) Ohm
1900 MHz	17.6 dB	(50.6 + j13.3) Ohm
1950 MHz	21.6 dB	(55.7 + j6.7) Ohm
2000 MHz	23.2 dB	(46.8 + j5.9) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

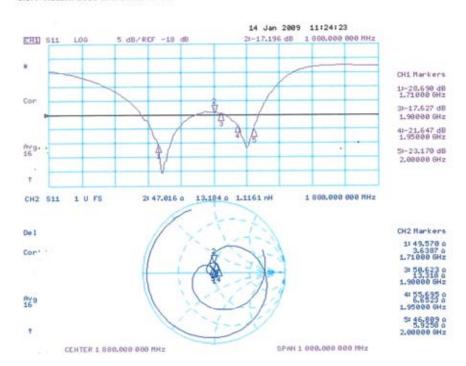
Certificate No: CD1880V3-1002_Jan09

Page 3 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:	EUT Type:	
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



Certificate No: CD1880V3-1002_Jan09

Page 4 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:		EUT Type:		Page 64 of 75
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 04 01 75

3.3.2 DASY4 H-Field Result

Test Laboratory: SPEAG Lab 2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002 H_CD1880_1002_090113

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 22.12.2008
- · Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
 Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Date/Time: 13.01.2009 15:43:46

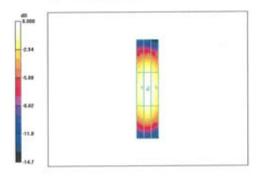
Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 0.460 A/m Probe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.487 A/m; Power Drift = -0.013 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.400 M2	0.418 M2	0.397 M2
Grid 4	Grid 5	Grid 6
0.441 M2	0.460 M2	0.436 M2
Grid 7	Grid 8	Grid 9
0.406 M2	0.426 M2	0.401 M2



0 dB = 0.460 A/m

Certificate No: CD1880V3-1002_Jan09

Page 5 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:	EUT Type:	
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wi	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

3.3.3 DASY4 E-Field Result

Date/Time: 14.01.2009 14:17:10

Test Laboratory: SPEAG Lab 2

E CD1880 1002 090114

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

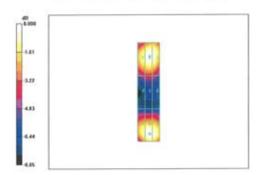
- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 137.6 V/m Probe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, -6.30 mm Reference Value = 154.8 V/m; Power Drift = -0.008 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3	
129.9 M2	136.8 M2	135.0 M2	
Grid 4	Grid 5	Grid 6	
87.0 M3	90.1 M3	87.0 M3	
Grid 7	Grid 8	Grid 9	
129.6 M2	137.6 M2	136.1 M2	



0 dB = 137.6V/m

Certificate No: CD1880V3-1002_Jan09

Page 6 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:	EUT Type:	
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone wit	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

4 Additional Measurements

4.1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7 B71
DASY PP Version	SEMCAD	V1.8 B184
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1730 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

4.2 Maximum Field values

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.478 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW forward power	148.3 V/m	
Maximum measured above low end	100 mW forward power	143.2 V/m	
Averaged maximum above arm	100 mW forward power	145.8 V/m	

Uncertainty for E-field measurement: 12.8% (k=2)

Certificate No: CD1880V3-1002_Jan09

Page 7 of 9

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT		Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 67 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

4.3.1 DASY4 H-Field Result

Date/Time: 21.01.2009 15:34:35

Test Laboratory: SPEAG Lab 2

H_CD1880_1002_090121

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002 Communication System: CW; Frequency: 1730 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

Probe: H3DV6 - SN6065; ; Calibrated: 22.12.2008

- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm @ 1730 MHz/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.478 A/m

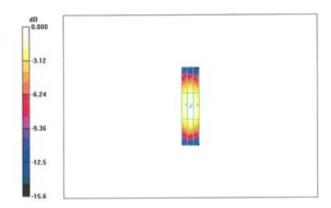
Probe Modulation Factor = 1.00

Reference Value = 0.508 A/m; Power Drift = -0.003 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3	
0.396 M2	0.412 M2	0.391 M2	
Grid 4	Grid 5	Grid 6	
0.457 M2	0.478 M2	0.453 M2	
Grid 7	Grid 8	Grid 9	
0.408 M2	0.429 M2	0.405 M2	



0 dB = 0.478 A/m

Certificate No: CD1880V3-1002_Jan09

Page 8 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 68 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with-	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

4.3.2 DASY4 E-Field Result

Date/Time: 21.01.2009 16:17:59

Test Laboratory: SPEAG Lab 2 E_CD1880_1002_090121

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002

Communication System: CW; Frequency: 1730 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 22.12.2008
- · Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 03.10.2008
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10 mm @ 1730 MHz/Hearing Aid Compatibility Test ($41 \times 181 \times 1$):

Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 148.3 V/m

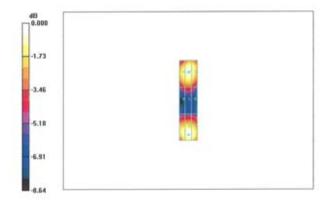
Probe Modulation Factor = 1.00

Reference Value = 168.2 V/m; Power Drift = 0.001 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3	
137.9 M2	143.2 M2	139.5 M2	
Grid 4	Grid 5	Grid 6	
98.3 M3	101.0 M3	96.9 M3	
Grid 7	Grid 8	Grid 9	
142.4 M2	148.3 M2	143.3 M2	



0 dB = 148.3 V/m

Certificate No: CD1880V3-1002_Jan09

Page 9 of 9

FCC ID: QMNRM-526	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager	
HAC Filename:	Test Dates:	EUT Type:		Page 69 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with-	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

15. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT NOKIA		NOKIA	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 70 of 75	
0903180521.QMN	4/6/2009		Dual-Band CDMA/EVDO Phone with+BT2.1+EDR		Fage 10 01 75

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FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 71 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with+	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	

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FCC ID: QMNRM-526	PCTEST	HAC (RF EMISSIONS) TEST REPORT NOKIA		Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 72 of 75
0903180521.QMN	4/6/2009	Dual-Band CDMA/EVDO Phone with-	Dual-Band CDMA/EVDO Phone with+BT2.1+EDR	